

## FEATURES

40-channel DAC in 64 Lead LFCSP and LQFP  
 Guaranteed monotonic to 16 bits  
 Maximum output voltage span of  $4 \times V_{REF}$  (20 V)  
 Nominal output voltage range of -4 V to +8 V  
 Multiple, independent output span available  
 System calibration function allowing user-programmable offset and gain  
 Clear function to user-defined SIGGND ( $\overline{CLR}$  pin)  
 Simultaneous update of DAC outputs ( $\overline{LDAC}$  pin)  
 Channel grouping and addressing features  
 Thermal Monitor Function

DSP/microcontroller-compatible serial interface

2.5 V to 5.5 V JEDEC-compliant digital levels

Power-on reset

Digital reset ( $\overline{RESET}$ )

## APPLICATIONS

Level setting in automatic test equipment (ATE)

Variable optical attenuators (VOA)

Optical switches

Industrial control systems

Instrumentation

## FUNCTIONAL BLOCK DIAGRAM

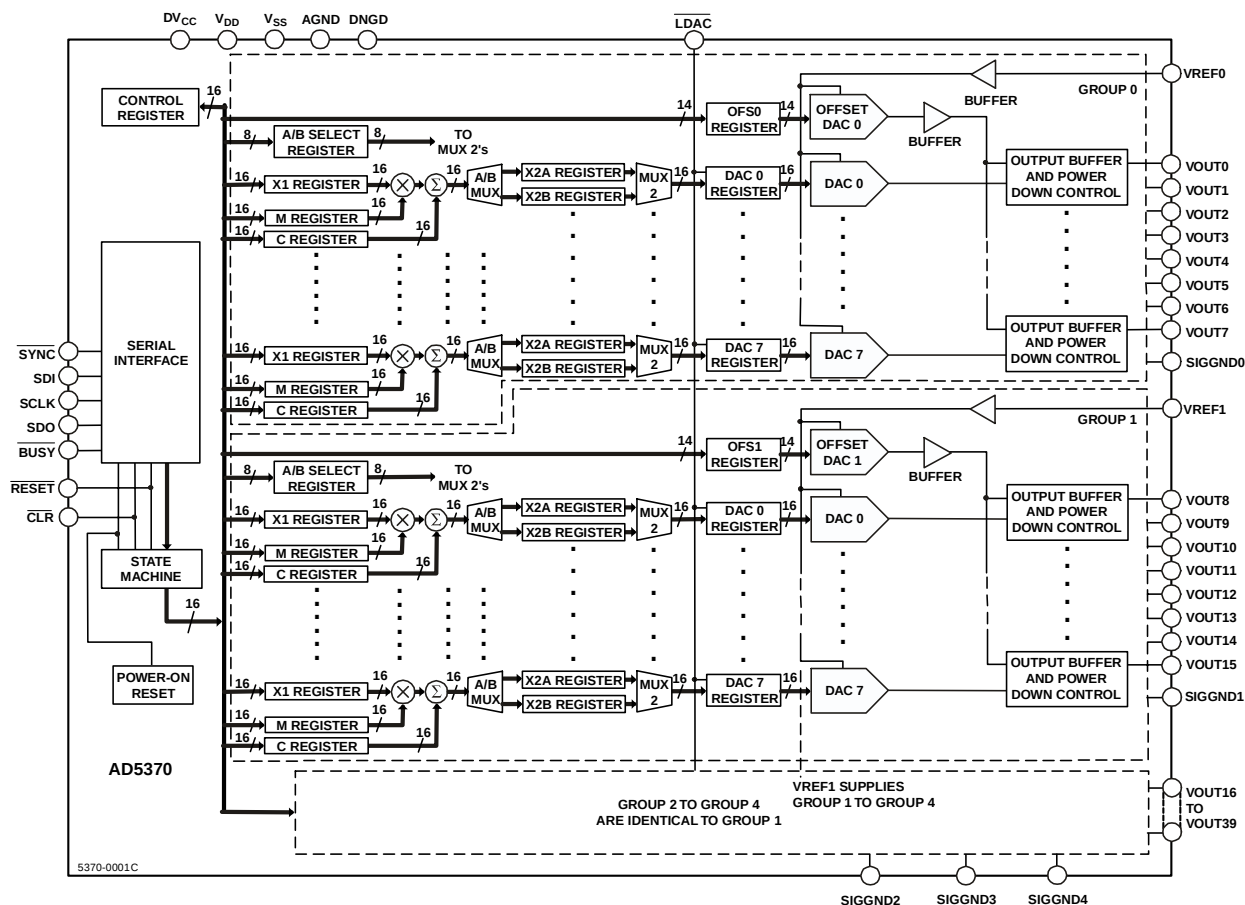


Figure 1.

## Rev. PrF

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## REVISION HISTORY

The AD5370 contains 40, 16-bit DACs in a single, 64-lead, LFCSP or LQFP package. The AD5370 provides buffered voltage outputs with a span 4 times the reference voltage. The gain and offset of each DAC can be independently trimmed to remove errors. For even greater flexibility, the device is divided into 5 groups of 8 DACs. Two offset DACs allow the output range of the groups to be altered. Group 0 can be adjusted by Offset DAC 0 and group 1 to group 4 can be adjusted by Offset DAC 2.

The AD5370 offers guaranteed operation over a wide supply range with  $V_{SS}$  from -4.5V to -16.5 V and  $V_{DD}$  from +8 V to +16.5 V. The output amplifier headroom requirement is 1.4 V operating with a load current of 1 mA.

The AD5370 has a high-speed serial interface, which is compatible with SPI®, QSPI™, MICROWIRE™, and DSP interface standards and can handle clock speeds of up to 50 MHz.

The DAC outputs are updated on reception of new data into the DAC registers. All the outputs can be updated simultaneously by taking the  $\overline{LDAC}$  input low. Each channel has a programmable gain and an offset adjust register.

Each DAC output is gained and buffered on-chip with respect to an external SIGGND input. The DAC outputs can also be switched to SIGGND via the CLR pin.

Table 1. High Channel Count Bipolar DACs

| Model      | Resolution | Nominal Output Span       | Output Channels | Linearity Error (LSB) | Package Description | Package Option |
|------------|------------|---------------------------|-----------------|-----------------------|---------------------|----------------|
| AD5360BCPZ | 16 Bits    | $4 \times V_{REF}$ (20 V) | 16              | $\pm 4$               | 56-Lead LFCSP       | CP-56          |
| AD5360BSTZ | 16 Bits    | $4 \times V_{REF}$ (20 V) | 16              | $\pm 4$               | 52-Lead LQFP        | ST-52          |
| AD5361BCPZ | 14 Bits    | $4 \times V_{REF}$ (20 V) | 16              | $\pm 1$               | 56-Lead LFCSP       | CP-56          |
| AD5361BSTZ | 14 Bits    | $4 \times V_{REF}$ (20 V) | 16              | $\pm 1$               | 52-Lead LQFP        | ST-52          |
| AD5362BCPZ | 16 Bits    | $4 \times V_{REF}$ (20 V) | 8               | $\pm 4$               | 56-Lead LFCSP       | CP-56          |
| AD5362BSTZ | 16 Bits    | $4 \times V_{REF}$ (20 V) | 8               | $\pm 4$               | 52-Lead LQFP        | ST-52          |
| AD5363BCPZ | 14 Bits    | $4 \times V_{REF}$ (20 V) | 8               | $\pm 1$               | 56-Lead LFCSP       | CP-56          |
| AD5363BSTZ | 14 Bits    | $4 \times V_{REF}$ (20 V) | 8               | $\pm 1$               | 52-Lead LQFP        | ST-52          |
| AD5370BCPZ | 16 Bits    | $4 \times V_{REF}$ (12 V) | 40              | $\pm 4$               | 64-Lead LFCSP       | CP-64          |
| AD5370BSTZ | 16 Bits    | $4 \times V_{REF}$ (12 V) | 40              | $\pm 4$               | 64-Lead LQFP        | ST-64          |
| AD5371BCPZ | 14 Bits    | $4 \times V_{REF}$ (12 V) | 40              | $\pm 1$               | 100-Ball CSPBGA     | BC-100-2       |
| AD5371BSTZ | 14 Bits    | $4 \times V_{REF}$ (12 V) | 40              | $\pm 1$               | 80-Lead LQFP        | ST-80          |
| AD5372BCPZ | 16 Bits    | $4 \times V_{REF}$ (12 V) | 32              | $\pm 4$               | 56-Lead LFCSP       | CP-56          |
| AD5372BSTZ | 16 Bits    | $4 \times V_{REF}$ (12 V) | 32              | $\pm 4$               | 64-Lead LQFP        | ST-64          |
| AD5373BCPZ | 14 Bits    | $4 \times V_{REF}$ (12 V) | 32              | $\pm 1$               | 56-Lead LFCSP       | CP-56          |
| AD5373BSTZ | 14 Bits    | $4 \times V_{REF}$ (12 V) | 32              | $\pm 1$               | 64-Lead LQFP        | ST-64          |

## SPECIFICATIONS

$DV_{CC} = 2.5\text{ V to }5.5\text{ V}$ ;  $V_{DD} = 8\text{ V to }16.5\text{ V}$ ;  $V_{SS} = -4.5\text{ V to }-16.5\text{ V}$ ;  $V_{REF} = 3\text{ V}$ ;  $AGND = DGND = SIGGND = 0\text{ V}$ ;  $R_L = \text{Open Circuit}$ ; Gain (m), Offset (c) and DAC Offset registers at default values; all specifications  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

**Table 2. Performance Characteristics**

| Parameter                                                                          | B Version <sup>1</sup>           | Unit                            | Test Conditions/Comments <sup>2</sup>                                                                          |
|------------------------------------------------------------------------------------|----------------------------------|---------------------------------|----------------------------------------------------------------------------------------------------------------|
| <b>ACCURACY</b>                                                                    |                                  |                                 |                                                                                                                |
| Resolution                                                                         | 16                               | Bits                            |                                                                                                                |
| Relative Accuracy                                                                  | $\pm 4$                          | LSB max                         | $-40^{\circ}\text{C to }+85^{\circ}\text{C}$ .                                                                 |
| Differential Nonlinearity                                                          | $\pm 1$                          | LSB max                         | Guaranteed monotonic by design over temperature.                                                               |
| Offset Error                                                                       | $\pm 20$                         | mV min/max                      | Before Calibration                                                                                             |
| Gain Error                                                                         | $\pm 20$                         | mV max                          | Before Calibration                                                                                             |
| Offset Error <sup>2</sup>                                                          | 100                              | $\mu\text{V max}$               | After Calibration                                                                                              |
| Gain Error <sup>2</sup>                                                            | 100                              | $\mu\text{V max}$               | After Calibration                                                                                              |
| Gain Error of Offset DAC                                                           | $\pm 35$                         | mV max                          | Positive or Negative Full Scale. See Offset DACs section for details                                           |
| VOUT Temperature Coefficient                                                       | 5                                | ppm FSR/ $^{\circ}\text{C typ}$ | Includes linearity, offset, and gain drift.                                                                    |
| DC Crosstalk <sup>2</sup>                                                          | 1.5                              | mV max                          | Typically 100 $\mu\text{V}$ . Measured channel at mid-scale, full-scale change on any other channel            |
| <b>REFERENCE INPUTS (<math>V_{REF0}</math>, <math>V_{REF1}</math>)<sup>2</sup></b> |                                  |                                 |                                                                                                                |
| $V_{REF}$ Input Current                                                            | 60                               | nA max                          | Per input. Typically $\pm 30\text{ nA}$ .                                                                      |
| $V_{REF}$ Range                                                                    | 2/5                              | V min/max                       | $\pm 2\%$ for specified operation.                                                                             |
| <b>SIGGND INPUT (SIGGND0 TO SIGGND4)<sup>2</sup></b>                               |                                  |                                 |                                                                                                                |
| DC Input Impedance                                                                 | 55                               | k $\Omega$ min                  | Typically 60 k $\Omega$ .                                                                                      |
| Input Range                                                                        | $\pm 0.5$                        | V min/max                       |                                                                                                                |
| <b>OUTPUT CHARACTERISTICS<sup>2</sup></b>                                          |                                  |                                 |                                                                                                                |
| Output Voltage Range                                                               | $V_{SS} + 1.4$<br>$V_{DD} - 1.4$ | V min<br>V max                  | $I_{LOAD} = 1\text{ mA}$ .<br>$I_{LOAD} = 1\text{ mA}$ .                                                       |
| Nominal Output Range                                                               | -4 to +8                         | V                               |                                                                                                                |
| Short Circuit Current                                                              | 10                               | mA max                          |                                                                                                                |
| Load Current                                                                       | $\pm 1$                          | mA max                          |                                                                                                                |
| Capacitive Load Stability                                                          | 2                                | nF max                          |                                                                                                                |
| DC Output Impedance                                                                | 0.5                              | $\Omega$ max                    |                                                                                                                |
| <b>DIGITAL INPUTS</b>                                                              |                                  |                                 |                                                                                                                |
| Input High Voltage                                                                 | 1.7<br>2.0                       | V min<br>V min                  | JEDEC compliant.<br>$IOV_{CC} = 2.5\text{ V to }3.6\text{ V}$ .<br>$IOV_{CC} = 3.6\text{ V to }5.5\text{ V}$ . |
| Input Low Voltage                                                                  | 0.8                              | V max                           | $IOV_{CC} = 2.5\text{ V to }5.5\text{ V}$ .                                                                    |
| Input Current                                                                      | $\pm 1$                          | $\mu\text{A max}$               | Except $\overline{\text{CLR}}$ and $\overline{\text{RESET}}$                                                   |
| Input Capacitance <sup>2</sup>                                                     | 10                               | pF max                          |                                                                                                                |
| <b>DIGITAL OUTPUTS (SDO)</b>                                                       |                                  |                                 |                                                                                                                |
| Output Low Voltage                                                                 | 0.5                              | V max                           | Sinking 200 $\mu\text{A}$ .                                                                                    |
| Output High Voltage (SDO)                                                          | $IOV_{CC} - 0.5$                 | V min                           | Sourcing 200 $\mu\text{A}$ .                                                                                   |
| High Impedance Leakage Current                                                     | -70                              | $\mu\text{A max}$               | SDO only.                                                                                                      |
| High Impedance Output Capacitance <sup>2</sup>                                     | 10                               | pF typ                          |                                                                                                                |

| Parameter                             | B Version <sup>1</sup> | Unit      | Test Conditions/Comments <sup>2</sup>                                                |
|---------------------------------------|------------------------|-----------|--------------------------------------------------------------------------------------|
| <b>POWER REQUIREMENTS</b>             |                        |           |                                                                                      |
| DV <sub>CC</sub>                      | 2.5/5.5                | V min/max |                                                                                      |
| V <sub>DD</sub>                       | 8/16.5                 | V min/max |                                                                                      |
| V <sub>SS</sub>                       | −4.5/−16.5             | V min/max |                                                                                      |
| Power Supply Sensitivity <sup>2</sup> |                        |           |                                                                                      |
| Δ Full Scale/Δ V <sub>DD</sub>        | −75                    | dB typ    |                                                                                      |
| Δ Full Scale/Δ V <sub>SS</sub>        | −75                    | dB typ    |                                                                                      |
| Δ Full Scale/Δ V <sub>CC</sub>        | −90                    | dB typ    |                                                                                      |
| DI <sub>CC</sub>                      | 2                      | mA max    | V <sub>CC</sub> = 5.5 V, V <sub>IH</sub> = V <sub>CC</sub> , V <sub>IL</sub> = GND.  |
| I <sub>DD</sub>                       | 14                     | mA max    | Outputs unloaded. DAC Outputs = 0V                                                   |
| I <sub>SS</sub>                       | 14                     | mA max    | Outputs unloaded. DAC Outputs = 0V                                                   |
| Power Dissipation                     |                        |           |                                                                                      |
| Power Dissipation Unloaded (P)        | 350                    | mW        | V <sub>SS</sub> = −5.5 V, V <sub>DD</sub> = +9.5 V, DV <sub>CC</sub> = 2.5V          |
| Junction Temperature                  | 130                    | °C max    | T <sub>J</sub> = T <sub>A</sub> + P <sub>TOTAL</sub> × θ <sub>J</sub> . <sup>3</sup> |

<sup>1</sup> Temperature range for B Version: −40°C to +85°C. Typical specifications are at 25°C.

<sup>2</sup> Guaranteed by design and characterization, not production tested.

<sup>3</sup> Where θ<sub>J</sub> represents the package thermal impedance.

## AC CHARACTERISTICS

DV<sub>CC</sub> = 2.5 V; V<sub>DD</sub> = 15 V; V<sub>SS</sub> = −15 V; V<sub>REF</sub> = 3 V; AGND = DGND = SIGGND = 0 V; C<sub>L</sub> = 200 pF to GND; R<sub>L</sub> = 10 kΩ to GND Gain (m), Offset (c) and DAC Offset registers at default values; all specifications T<sub>MIN</sub> to T<sub>MAX</sub>, unless otherwise noted.

**Table 3. AC Characteristics**

| Parameter                             | B Version <sup>1</sup> | Unit                       | Test Conditions/Comments                               |
|---------------------------------------|------------------------|----------------------------|--------------------------------------------------------|
| <b>DYNAMIC PERFORMANCE</b>            |                        |                            |                                                        |
| Output Voltage Settling Time          | TBD                    | μs typ                     | Full-scale change                                      |
|                                       | 30                     | μs max                     |                                                        |
| Slew Rate                             | 1                      | V/μs typ                   |                                                        |
| Digital-to-Analog Glitch Energy       | 20                     | nV-s typ                   |                                                        |
| Glitch Impulse Peak Amplitude         | 10                     | mV max                     |                                                        |
| Channel-to-Channel Isolation          | 100                    | dB typ                     | V <sub>REF</sub> (+) = 2 V p-p, 1 kHz.                 |
| DAC-to-DAC Crosstalk                  | 40                     | nV-s typ                   | Between DACs inside a group.                           |
|                                       | 10                     | nV-s typ                   | Between DACs from different groups.                    |
| Digital Crosstalk                     | 0.1                    | nV-s typ                   |                                                        |
| Digital Feedthrough                   | 1                      | nV-s typ                   | Effect of input bus activity on DAC output under test. |
| Output Noise Spectral Density @ 1 kHz | 250                    | nV/(Hz) <sup>1/2</sup> typ | V <sub>REF</sub> = 0 V.                                |

## TIMING CHARACTERISTICS

$DV_{CC} = 2.3 \text{ V to } 5.5 \text{ V}$ ;  $V_{DD} = 8 \text{ V to } 16.5 \text{ V}$ ;  $V_{SS} = -4.5 \text{ V to } -16.5 \text{ V}$ ;  $V_{REF} = 3 \text{ V}$ ;  $AGND = DGND = SIGGND = 0 \text{ V}$ ;  $R_L = \text{Open Circuit}$ ; Gain (m), Offset (c) and DAC Offset registers at default values; all specifications  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

## SPI INTERFACE (Figure 4 and Figure 5)

| Parameter <sup>1, 2, 3</sup> | Limit at $T_{MIN}, T_{MAX}$ | Unit                  | Description                                                             |
|------------------------------|-----------------------------|-----------------------|-------------------------------------------------------------------------|
| $t_1$                        | 20                          | ns min                | SCLK Cycle Time.                                                        |
| $t_2$                        | 8                           | ns min                | SCLK High Time.                                                         |
| $t_3$                        | 8                           | ns min                | SCLK Low Time.                                                          |
| $t_4$                        | 11                          | ns min                | $\overline{SYNC}$ Falling Edge to SCLK Falling Edge Setup Time.         |
| $t_5$                        | 20                          | ns min                | Minimum $\overline{SYNC}$ High Time.                                    |
| $t_6$                        | 10                          | ns min                | 24th SCLK Falling Edge to $\overline{SYNC}$ Rising Edge.                |
| $t_7$                        | 5                           | ns min                | Data Setup Time.                                                        |
| $t_8$                        | 5                           | ns min                | Data Hold Time.                                                         |
| $t_9^3$                      | 42                          | ns max                | $\overline{SYNC}$ Rising Edge to $\overline{BUSY}$ Falling Edge.        |
| $t_{10}$                     | 1.25                        | $\mu\text{s max}$     | $\overline{BUSY}$ Pulse Width Low (Single-Channel Update.) See Table 7. |
| $t_{11}$                     | 500                         | ns max                | Single-Channel Update Cycle Time                                        |
| $t_{12}$                     | 20                          | ns min                | 24th SCLK Falling Edge to $\overline{LDAC}$ Falling Edge.               |
| $t_{13}$                     | 10                          | ns min                | $\overline{LDAC}$ Pulse Width Low.                                      |
| $t_{14}$                     | 3                           | $\mu\text{s max}$     | $\overline{BUSY}$ Rising Edge to DAC Output Response Time.              |
| $t_{15}$                     | 0                           | ns min                | $\overline{BUSY}$ Rising Edge to $\overline{LDAC}$ Falling Edge.        |
| $t_{16}$                     | 3                           | $\mu\text{s max}$     | $\overline{LDAC}$ Falling Edge to DAC Output Response Time.             |
| $t_{17}$                     | 20/30                       | $\mu\text{s typ/max}$ | DAC Output Settling Time.                                               |
| $t_{18}$                     | 125                         | ns max                | $\overline{CLR/RESET}$ Pulse Activation Time.                           |
| $t_{19}$                     | 30                          | ns min                | $\overline{RESET}$ Pulse Width Low.                                     |
| $t_{20}$                     | 400                         | $\mu\text{s max}$     | $\overline{RESET}$ Time Indicated by $\overline{BUSY}$ Low.             |
| $t_{21}$                     | 270                         | ns min                | Minimum $\overline{SYNC}$ High Time in Readback Mode.                   |
| $t_{22}^5$                   | 25                          | ns max                | SCLK Rising Edge to SDO Valid.                                          |

<sup>1</sup> Guaranteed by design and characterization, not production tested.

<sup>2</sup> All input signals are specified with  $t_r = t_f = 2 \text{ ns}$  (10% to 90% of  $V_{CC}$ ) and timed from a voltage level of 1.2 V.

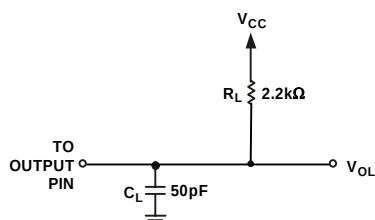


Figure 2. Load Circuit for  $\overline{BUSY}$  Timing Diagram

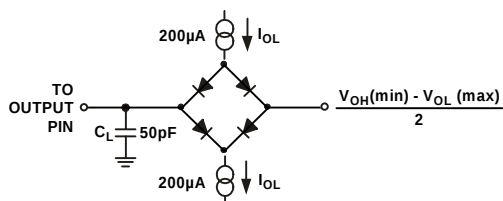
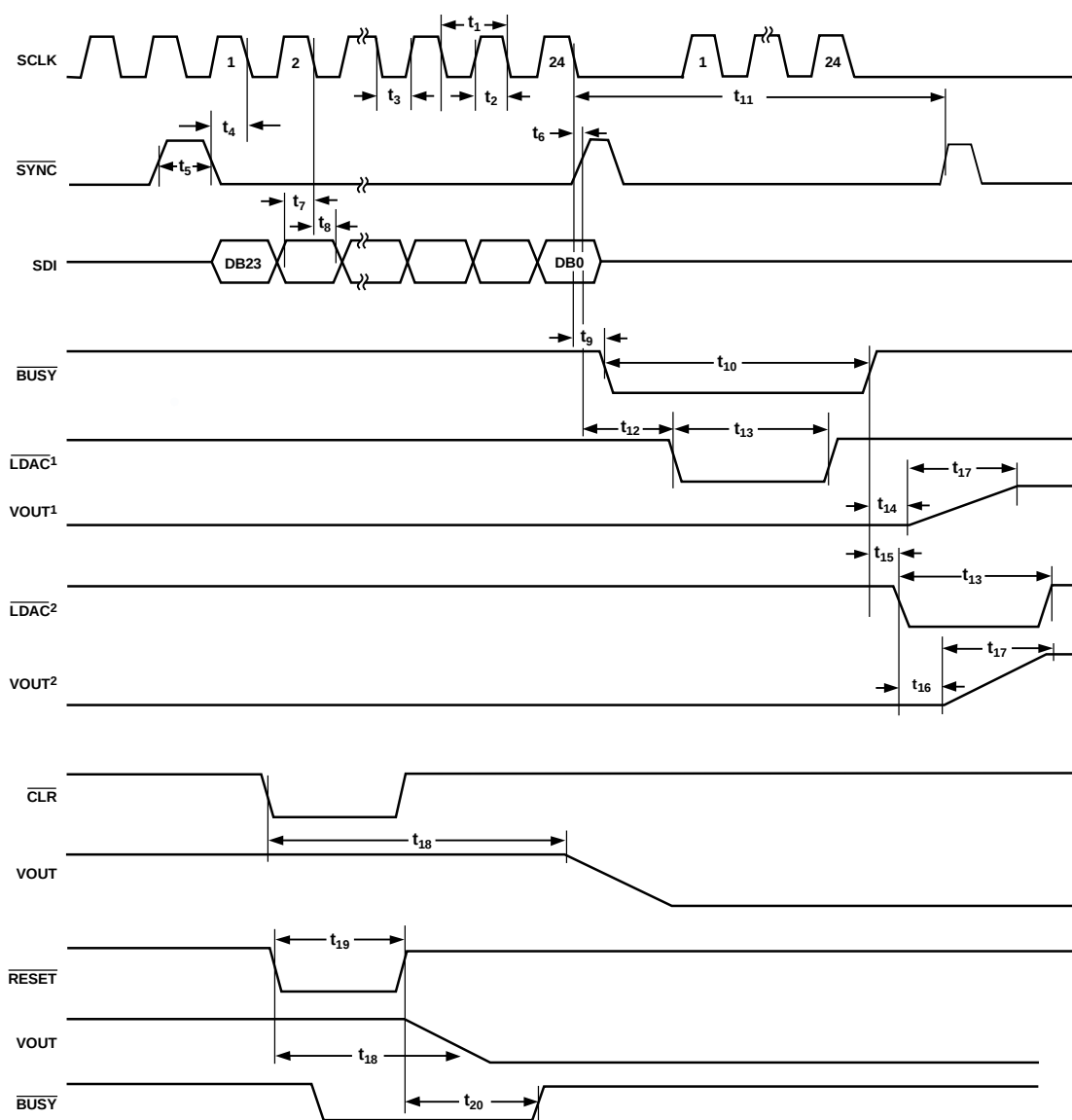


Figure 3. Load Circuit for SDO Timing Diagram



<sup>1</sup>LDAC ACTIVE DURING BUSY.  
<sup>2</sup>LDAC ACTIVE AFTER BUSY.

Figure 4. SPI Write Timing

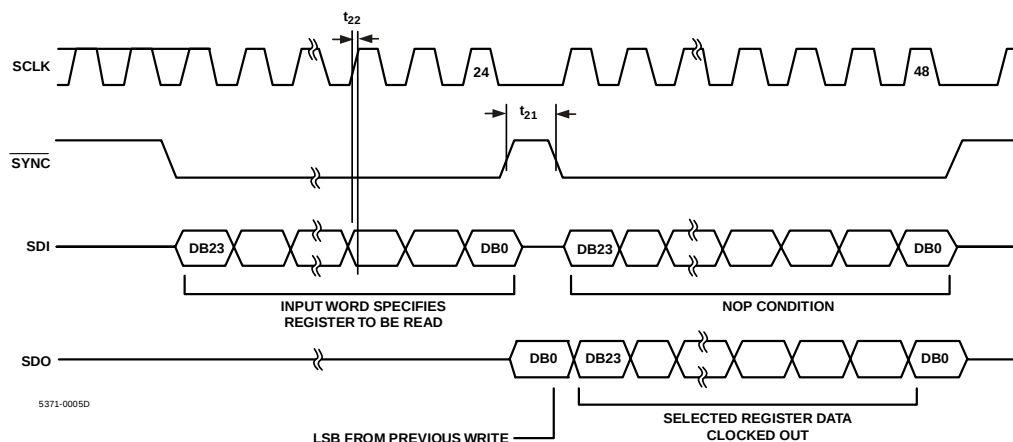


Figure 5. SPI Read Timing

## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless otherwise noted.

Transient currents of up to 100 mA do not cause SCR latch-up.

**Table 4. Absolute Maximum Ratings**

| Parameter                             | Rating                               |
|---------------------------------------|--------------------------------------|
| $V_{DD}$ to AGND                      | −0.3 V to +17 V                      |
| $V_{SS}$ to AGND                      | −17 V to +0.3 V                      |
| $DV_{CC}$ to DGND                     | −0.3 V to +7 V                       |
| Digital Inputs to DGND                | −0.3 V to $V_{CC} + 0.3$ V           |
| Digital Outputs to DGND               | −0.3 V to $V_{CC} + 0.3$ V           |
| $V_{REF1}$ , $V_{REF2}$ to AGND       | −0.3 V to +7 V                       |
| VOUT0–VOUT39 to AGND                  | $V_{SS} - 0.3$ V to $V_{DD} + 0.3$ V |
| SIGGND to AGND                        | −1 V to +1 V                         |
| AGND to DGND                          | −0.3 V to +0.3 V                     |
| Operating Temperature Range ( $T_A$ ) |                                      |
| Industrial (B Version)                | −40°C to +85°C                       |
| Storage Temperature Range             | −65°C to +150°C                      |
| Junction Temperature ( $T_J$ max)     | 130°C                                |
| $\theta_{JA}$ Thermal Impedance       |                                      |
| 64-LFCSP                              | 25°C/W                               |
| 64-LQFP                               | 45.5°C/W                             |
| Reflow Soldering                      |                                      |
| Peak Temperature                      | 230°C                                |
| Time at Peak Temperature              | 10 s to 40 s                         |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



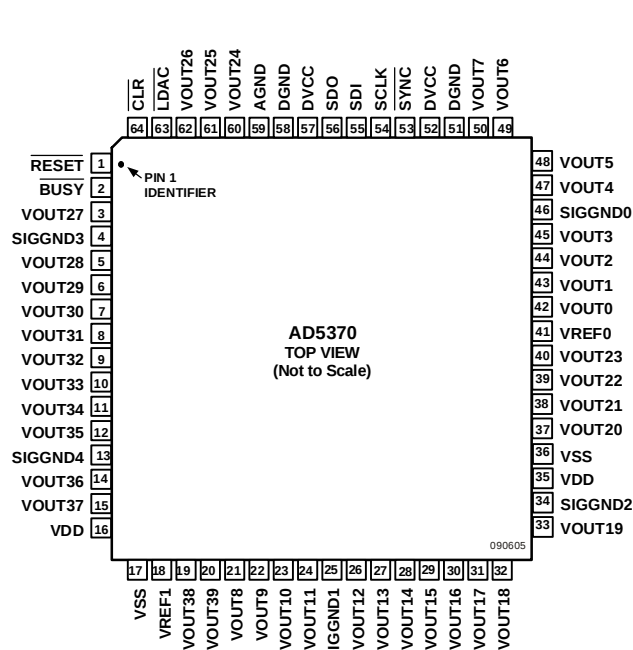


Figure 6.64-Lead LQFP Pin Configuration

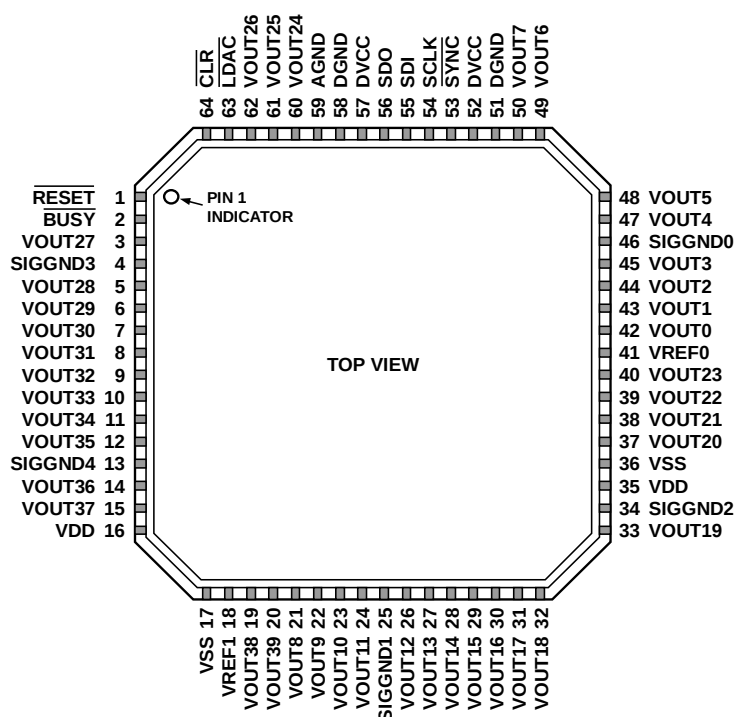


Figure 7.64-Lead LFCSP Pin Configuration

Table 5. Pin Function Descriptions

| Pin                      | Function                                                                                                                                                                                                               |
|--------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| DV <sub>CC</sub>         | Logic Power Supply; 2.5 V to 5.5 V. These pins should be decoupled with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.                                                                                      |
| IOV <sub>CC</sub>        | Power supply for interface logic.                                                                                                                                                                                      |
| V <sub>SS</sub>          | Negative Analog Power Supply; $-11.4$ V to $-16.5$ V for specified performance. These pins should be decoupled with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.                                          |
| V <sub>DD</sub>          | Positive Analog Power Supply; $+11.4$ V to $+16.5$ V for specified performance. These pins should be decoupled with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.                                          |
| AGND                     | Ground for All Analog Circuitry. All AGND pins should be connected to the AGND plane.                                                                                                                                  |
| DGND                     | Ground for All Digital Circuitry. All DGND pins should be connected to the DGND plane.                                                                                                                                 |
| V <sub>REF0</sub>        | Reference Input for DACs 0 to 7. This voltage is referred to AGND.                                                                                                                                                     |
| V <sub>REF1</sub>        | Reference Input for DACs 8 to 39. This voltage is referred to AGND.                                                                                                                                                    |
| VOUT0 to VOUT39          | DAC Outputs. Buffered analog outputs for each of the 40 DAC channels. Each analog output is capable of driving an output load of 10 k $\Omega$ to ground. Typical output impedance of these amplifiers is 1 $\Omega$ . |
| $\overline{\text{SYNC}}$ | Active Low Input. This is the frame synchronization signal for the serial interface.                                                                                                                                   |
| SCLK                     | Serial Clock Input. Data is clocked into the shift register on the falling edge of SCLK. This pin operates at clock speeds up to 50 MHz.                                                                               |
| SDI                      | Serial Data Input. Data must be valid on the falling edge of SCLK.                                                                                                                                                     |
| SDO                      | Serial Data Output. CMOS output. SDO can be used for readback. Data is clocked out on SDO on the rising edge of SCLK and is valid on the falling edge of SCLK.                                                         |
| $\overline{\text{CLR}}$  | Asynchronous Clear Input (level sensitive, active low). See the Clear Function section for more information                                                                                                            |
| $\overline{\text{LDAC}}$ | Load DAC Logic Input (active low). See the $\overline{\text{BUSY}}$ AND $\overline{\text{LDAC}}$ FUNCTIONS section for more information                                                                                |

| Pin            | Function                                                                                                                                                                                     |
|----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| RESET          | Asynchronous Digital Reset Input                                                                                                                                                             |
| BUSY           | Digital Input/Open-Drain Output. $\overline{\text{BUSY}}$ is open-drain when an output. See the $\overline{\text{BUSY}}$ AND $\overline{\text{LDAC}}$ FUNCTIONS section for more information |
| SIGGND0        | Reference Ground for DACs 0 to 7. VOUT0 to VOUT7 are referenced to this voltage.                                                                                                             |
| SIGGND1        | Reference Ground for DACs 8 to 15. VOUT7 to VOUT15 are referenced to this voltage.                                                                                                           |
| SIGGND1        | Reference Ground for DACs 16 to 23. VOUT16 to VOUT23 are referenced to this voltage.                                                                                                         |
| SIGGND3        | Reference Ground for DACs 24 and 31. VOUT24 to VOUT31 are referenced to this voltage.                                                                                                        |
| SIGGND4        | Reference Ground for DACs 32 to 39. VOUT32 to VOUT39 are referenced to this voltage.                                                                                                         |
| EXPOSED PADDLE | The Lead Free Chip Scale Package (LFCSP) has an exposed paddle on the underside. This should be connected to $V_{SS}$                                                                        |

## TERMINOLOGY

### Relative Accuracy

Relative accuracy, or endpoint linearity, is a measure of the maximum deviation from a straight line passing through the endpoints of the DAC transfer function. It is measured after adjusting for zero-scale error and full-scale error and is expressed in least significant bits (LSB).

### Differential Nonlinearity

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of 1 LSB maximum ensures monotonicity.

### Zero-Scale Error

Zero-scale error is the error in the DAC output voltage when all 0s are loaded into the DAC register.

Zero-scale error is a measure of the difference between VOUT (actual) and VOUT (ideal) expressed in mV. Zero-scale error is mainly due to offsets in the output amplifier.

### Full-Scale Error

Full-scale error is the error in DAC output voltage when all 1s are loaded into the DAC register.

Full-scale error is a measure of the difference between VOUT (actual) and VOUT (ideal) expressed in mV. It does not include zero-scale error.

**Gain Error** Gain error is the difference between full-scale error and zero-scale error. It is expressed in mV.

$$\text{Gain Error} = \text{Full-Scale Error} - \text{Zero-Scale Error}$$

### VOUT Temperature Coefficient

This includes output error contributions from linearity, offset, and gain drift.

### DC Output Impedance

DC output impedance is the effective output source resistance. It is dominated by package lead resistance.

### DC Crosstalk

The DAC outputs are buffered by op amps that share common  $V_{DD}$  and  $V_{SS}$  power supplies. If the dc load current changes in one channel (due to an update), this can result in a further dc change in one or more channel outputs. This effect is more significant at high load currents and reduces as the load currents are reduced. With high impedance loads, the effect is virtually immeasurable. Multiple  $V_{DD}$  and  $V_{SS}$  terminals are provided to minimize dc crosstalk.

### Output Voltage Settling Time

The amount of time it takes for the output of a DAC to settle to a specified level for a full-scale input change.

### Digital-to-Analog Glitch Energy

The amount of energy injected into the analog output at the major code transition. It is specified as the area of the glitch in nV-s. It is measured by toggling the DAC register data between 0x1FFF and 0x2000.

### Channel-to-Channel Isolation

Channel-to-channel isolation refers to the proportion of input signal from one DAC's reference input that appears at the output of another DAC operating from another reference. It is expressed in dB and measured at midscale.

### DAC-to-DAC Crosstalk

DAC-to-DAC crosstalk is the glitch impulse that appears at the output of one converter due to both the digital change and subsequent analog output change at another converter. It is specified in nV-s.

### Digital Crosstalk

The glitch impulse transferred to the output of one converter due to a change in the DAC register code of another converter is defined as the digital crosstalk and is specified in nV-s.

### Digital Feedthrough

When the device is not selected, high frequency logic activity on the device's digital inputs can be capacitively coupled both across and through the device to show up as noise on the VOUT pins. It can also be coupled along the supply and ground lines. This noise is digital feedthrough.

### Output Noise Spectral Density

Output noise spectral density is a measure of internally generated random noise. Random noise is characterized as a spectral density (voltage per  $\sqrt{\text{Hz}}$ ). It is measured by loading all DACs to midscale and measuring noise at the output. It is measured in  $\text{nV}/(\text{Hz})^{1/2}$ .

## FUNCTIONAL DESCRIPTION

### DAC ARCHITECTURE—GENERAL

The AD5370 contains 40 DAC channels and 40 output amplifiers in a single package. The architecture of a single DAC channel consists of a 16-bit resistor-string DAC followed by an output buffer amplifier. The resistor-string section is simply a string of resistors, each of value  $R$ , from  $V_{REF}$  to AGND. This type of architecture guarantees DAC monotonicity. The 16-bit binary digital code loaded to the DAC register determines at which node on the string the voltage is tapped off before being

fed into the output amplifier. The output amplifier multiplies the DAC out voltage by 4. The output span is 12 V with a 3 V reference and 20 V with a 5 V reference.

### CHANNEL GROUPS

The 40 DAC channels of the AD5370 are arranged into five groups of 8 channels. The eight DACs of Group 0 derive their reference voltage from  $V_{REF0}$ , those of Group 1 from  $V_{REF0}$ , while the remaining groups derive their reference voltage from  $V_{REF1}$ . Each group has its own signal ground pin

Table 6. AD5370 Registers

| Register Name         | Word Length (Bits) | Description                                                                                                                                                                                                                   |
|-----------------------|--------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| X1A (group)(channel)  | 16                 | Input data register A, one for each DAC channel.                                                                                                                                                                              |
| X1B (group) (channel) | 16                 | Input data register B, one for each DAC channel.                                                                                                                                                                              |
| M (group) (channel)   | 16                 | Gain trim registers, one for each DAC channel.                                                                                                                                                                                |
| C (group) (channel)   | 16                 | Offset trim registers, one for each DAC channel.                                                                                                                                                                              |
| X2A (group)(channel)  | 16                 | Output data register A, one for each DAC channel. These registers store the final, calibrated DAC data after gain and offset trimming. They are not readable, nor directly writable.                                          |
| X2B (group) (channel) | 16                 | Output data register B, one for each DAC channel. These registers store the final, calibrated DAC data after gain and offset trimming. They are not readable, nor directly writable.                                          |
| DAC (group) (channel) |                    | Data registers from which the DACs take their final input data. The DAC registers are updated from the X2A or X2B registers. They are not readable, nor directly writable.                                                    |
| OFS0                  | 14                 | Offset DAC 0 data register, sets offset for Group 0.                                                                                                                                                                          |
| OFS1                  | 14                 | Offset DAC 1 data register, sets offset for Group 1.                                                                                                                                                                          |
| Control               | 3                  | Bit 2 = A/B. 0 = global selection of X1A input data registers. 1 = X1B registers.<br>Bit 1 = Enable Temp Shutdown. 0 = disable temp shutdown. 1 = enable.<br>Bit 0 = Soft Power Down. 0 = soft power up. 1 = soft power down. |
| A/B Select 0          | 8                  | Each bit in this register determines if a DAC in Group 0 takes its data from register X2A or X2B (0 = X2A, 1 = X2B)                                                                                                           |
| A/B Select 1          | 8                  | Each bit in this register determines if a DAC in Group 1 takes its data from register X2A or X2B (0 = X2A, 1 = X2B)                                                                                                           |
| A/B Select 2          | 8                  | Each bit in this register determines if a DAC in Group 2 takes its data from register X2A or X2B (0 = X2A, 1 = X2B)                                                                                                           |
| A/B Select 3          | 8                  | Each bit in this register determines if a DAC in Group 3 takes its data from register X2A or X2B (0 = X2A, 1 = X2B)                                                                                                           |
| A/B Select 4          | 8                  | Each bit in this register determines if a DAC in Group 4 takes its data from register X2A or X2B (0 = X2A, 1 = X2B)                                                                                                           |

## A/ B REGISTERS AND GAIN/OFFSET ADJUSTMENT

Each DAC channel has seven data registers. The actual DAC data word can be written to either the X1A or X1B input register, depending on the setting of the  $\overline{A/B}$  bit in the Control Register. If the  $\overline{A/B}$  bit is 0, data will be written to the X1A register. If the  $\overline{A/B}$  bit is 1, data will be written to the X1B register. Note that this single bit is a global control and affects every DAC channel in the device. It is not possible to set up the device on a per-channel basis so that some writes are to X1A registers and some writes are to X1B registers.

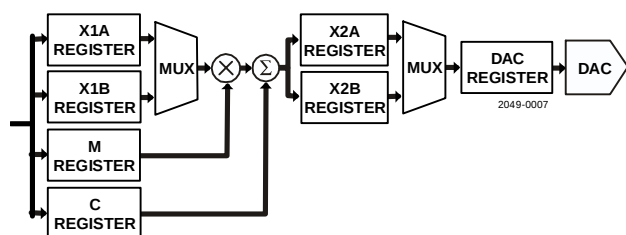


Figure 8. Data Registers Associated With Each DAC Channel

Each DAC channel also has a gain (M) and offset (C) register, which allow trimming out of the gain and offset errors of the entire signal chain. Data from the X1A register is operated on by a digital multiplier and adder controlled by the contents of the M and C registers. The calibrated DAC data is then stored in the X2A register. Similarly, data from the X1B register is operated on by the multiplier and adder and stored in the X2B register.

Although a multiplier and adder symbol are shown for each channel, there is only one multiplier and one adder in the device, which are shared between all channels. This has implications for the update speed when several channels are updated at once, as described later.

Each time data is written to the X1A register, or to the M or C register with the  $\overline{A/B}$  control bit set to 0, the X2A data is recalculated and the X2A register is automatically updated. Similarly, X2B is updated each time data is written to X1B, or to M or C with  $\overline{A/B}$  set to 1. The X2A and X2B registers are not readable, nor directly writable by the user.

Data output from the X2A and X2B registers is routed to the final DAC register by a multiplexer. Whether each individual DAC takes its data from the X2A or X2B register is controlled by an 8-bit A/B Select Register associated with each group of 8 DACs. If a bit in this register is 0, the DAC takes its data from the X2A register; if 1 the DAC takes its data from the X2B register (bit 0 controls DAC 0, bit 1 controls DAC 1 etc.).

Note that, since there are 40 bits in 5 registers, it is possible to set up, on a per-channel basis, whether each DAC takes its data from the X2A or X2B register. A global Command is also provided that sets all bits in the A/B Select Registers to 0 or to 1.

## LOAD DAC

All DACs in the AD5370 can be updated simultaneously by taking  $\overline{LDAC}$  low, when each DAC register will be updated from either its X2A or X2B register, depending on the setting of the A/B select registers. The DAC register is not readable, nor directly writable by the user.

## OFFSET DACS

In addition to the gain and offset trim for each DAC, there are two 14-bit Offset DACs, one for Group 0, one for Group 1 to Group 4. These allow the output range of all DACs connected to them to be offset within a defined range. Thus, subject to the limitations of headroom, it is possible to set the output range of Group 0, or Groups 1 to Group 4 to be unipolar positive, unipolar negative, or bipolar, either symmetrical or asymmetrical about zero volts. The DACs in the AD5370 are factory trimmed with the Offset DACs set at their default values. This gives the best offset and gain performance for the default output range and span.

When the output range is adjusted by changing the value of the Offset DAC an extra offset is introduced due to the gain error of the Offset DAC. The amount of offset is dependent on the magnitude of the reference and how much the Offset DAC moves from its default value. This offset is quoted on the specification page. The worst case offset occurs when the Offset DAC is at positive or negative full-scale. This value can be added to the offset present in the main DAC of a channel to give an indication of the overall offset for that channel. In most cases the offset can be removed by programming the channels C register with an appropriate value. The extra offset cause by the Offset DACs only needs to be taken into account when the Offset DAC is changed from its default value. Figure 9 shows the allowable code range which may be loaded to the Offset DAC and this is dependant on the reference value used. Thus, for a 5V reference, the Offset DAC should not be programmed with a value greater than 8192 (0x2000).

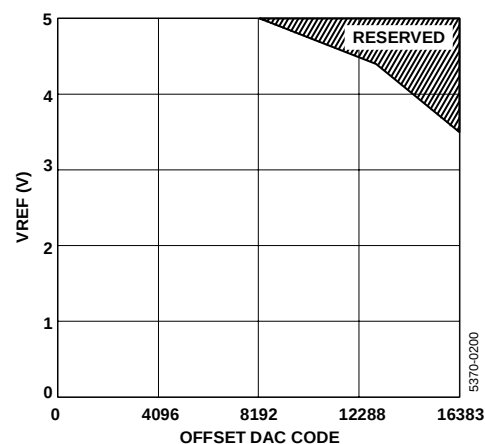


Figure 9. Offset DAC Code Range

## OUTPUT AMPLIFIER

As the output amplifiers can swing to 1.4 V below the positive supply and 1.4 V above the negative supply, this limits how much the output can be offset for a given reference voltage. For example, it is not possible to have a unipolar output range of 20V, since the maximum supply voltage is  $\pm 16.5$  V.

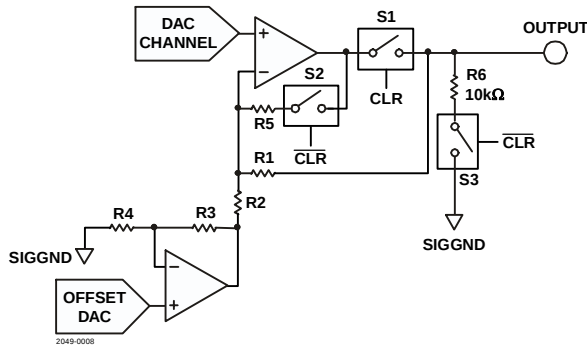


Figure 10. Output Amplifier and Offset DAC

Figure 10 shows details of a DAC output amplifier and its connections to the Offset DAC. On power up, S1 is open, disconnecting the amplifier from the output. S3 is closed, so the output is pulled to SIGGND (R1 and R2 are very much greater than R6). S2 is also closed to prevent the output amplifier being open-loop. If CLR is low at power-up, the output will remain in this condition until CLR is taken high. The DAC registers can be programmed, and the outputs will assume the programmed values when CLR is taken high. Even if CLR is high at power-up, the output will remain in the above condition until  $V_{DD} > 6$  V and  $V_{SS} < -4$  V and the initialization sequence has finished. The outputs will then go to their power-on default value.

## TRANSFER FUNCTION

From the foregoing, it can be seen that the output voltage of a DAC in the AD5370 depends on the value in the input register, the value of the M and C registers, and the offset from the Offset DAC. The transfer function is given by:

Code applied to DAC from X1A or X1B register:-

$$\text{DAC\_CODE} = \text{INPUT\_CODE} \times (m+1)/2^{16} + c - 2^{15}$$

DAC output voltage:-

$$V_{\text{OUT}} = 4 \times V_{\text{REF}} \times (\text{DAC\_CODE} - \text{OFFSET\_CODE})/2^{16} + V_{\text{SIGGND}}$$

Notes

DAC\_CODE should be within the range of 0 to 65535.

For 12 V span  $V_{\text{REF}} = 3.0$  V.

For 20 V span  $V_{\text{REF}} = 5.0$  V.

X1A or X1B default code = 21844

$m$  = code in gain register - default code =  $2^{16} - 1$ .

$c$  = code in offset register - default code =  $2^{15}$ .

OFFSET\_CODE is the code loaded to the offset DAC. It is multiplied by 4 in the transfer function as this DAC is a 14 bit device. On power up the default code loaded to the offset DAC

is 5461 (0x1555). With a 3V reference this gives a span of -4 V to +8 V.

## REFERENCE SELECTION

The AD5370 has two reference input pins. The voltage applied to the reference pins determines the output voltage span on VOUT0 to VOUT39. VREF0 determines the voltage span for VOUT0 to VOUT7 (Group 0) and VREF1 determines the voltage span for VOUT8 to VOUT39 (Group 1 to Group 4). The reference voltage applied to each VREF pin can be different, if required, allowing the groups to have a different voltage spans. The output voltage range can be adjusted further by programming the offset and gain registers for each channel as well as programming the offset DACs. If the offset and gain features are not used (i.e. the m and c registers are left at their default values) the required reference levels can be calculated as follows:

$$V_{\text{REF}} = (V_{\text{OUT}_{\text{max}}} - V_{\text{OUT}_{\text{min}}})/4$$

If the offset and gain features of the AD5370 are used, then the required output range is slightly different. The chosen output range should take into account the system offset and gain errors that need to be trimmed out. Therefore, the chosen output range should be larger than the actual, required range.

The required reference levels can be calculated as follows:

1. Identify the nominal output range on VOUT.
2. Identify the maximum offset span and the maximum gain required on the full output signal range.
3. Calculate the new maximum output range on VOUT including the expected maximum offset and gain errors.
4. Choose the new required  $V_{\text{OUT}_{\text{max}}}$  and  $V_{\text{OUT}_{\text{min}}}$ , keeping the VOUT limits centered on the nominal values. Note that  $V_{\text{DD}}$  and  $V_{\text{SS}}$  must provide sufficient headroom.
5. Calculate the value of VREF as follows:

$$V_{\text{REF}} = (V_{\text{OUTMAX}} - V_{\text{OUTMIN}})/4$$

## Reference Selection Example

Nominal Output Range = 12V (-4V to +8V)

Offset Error =  $\pm 70$  mV

Gain Error =  $\pm 3\%$

SIGGND = AGND = 0V

- 1) Gain Error =  $\pm 3\%$   
 $\Rightarrow$  Maximum Positive Gain Error = +3%  
 $\Rightarrow$  Output Range incl. Gain Error =  $12 + 0.03(12) = 12.36$  V
- 2) Offset Error =  $\pm 70$  mV  
 $\Rightarrow$  Maximum Offset Error Span =  $2(70 \text{ mV}) = 0.14$  V  
 $\Rightarrow$  Output Range including Gain Error and Offset Error =

$$12.36\text{V} + 0.14\text{V} = 12.5\text{V}$$

### 3) *VREF Calculation*

*Actual Output Range* = 12.5V, that is -4.25V to +8.25V (centered);

$$V_{REF} = (8.25\text{V} + 4.25\text{V})/4 = 3.125\text{V}$$

If the solution yields an inconvenient reference level, the user can adopt one of the following approaches:

1. Use a resistor divider to divide down a convenient, higher reference level to the required level.
2. Select a convenient reference level above  $V_{REF}$  and modify the Gain and Offset registers to digitally downsize the reference. In this way the user can use almost any convenient reference level but may reduce the performance by overcompaction of the transfer function.
3. Use a combination of these two approaches

## CALIBRATION

The user can perform a system calibration on the AD5370 to reduce gain and offset errors to below 1 LSB. This is achieved by calculating new values for the M and C registers and reprogramming them.

### **Reducing Zero-scale and Full-scale Error**

Zero-scale error can be reduced as follows:

1. Set the output to the lowest possible value.
2. Measure the actual output voltage and compare it with the required value. This gives the zero-scale error.
3. Calculate the number of LSBs equivalent to the error and subtract this from the default value of the C register. Note that only negative zero-scale error can be reduced.

Full-scale error can be reduced as follows:

1. Measure the zero-scale error.
2. Set the output to the highest possible value.
3. Measure the actual output voltage and compare it with the required value. Add this error to the zero-scale error. This is the full-scale error.
4. Calculate the number of LSBs equivalent to the full-scale error and subtract it from the default value of the M register. Note that only positive full-scale error can be reduced.
5. The M and C registers should not be programmed until both zero-scale and full-scale errors have been calculated.

### **AD5370 Calibration Example**

This example assumes that a -4 V to +8 V output is required. The DAC output is set to -4 V but measured at -4.03 V. This gives an zero-scale error of -30 mV.

1.  $1 \text{ LSB} = 12 \text{ V}/65536 = 183.105 \mu\text{V}$
2.  $30 \text{ mV} = 164 \text{ LSB}$
3. 164 LSB should be added to the default C register value:  
 $(32768 + 164) = 32932$
4. 32932 should be programmed to the C register

The full-scale error can now be removed. The output is set to +8 V and a value of +8.02 V is measured. The full-scale error is  $+20 \text{ mV} - (-30 \text{ mV}) = +50 \text{ mV}$ . This is a full-scale error of +50 mV.

1.  $50 \text{ mV} = 273 \text{ LSBs}$
2. 273 LSB should be subtracted from the default M register value:  $(65535 - 273) = 65262$
3. 65262 should be programmed to the M register

## ADDITIONAL CALIBRATION

The techniques described in the previous text are usually enough to reduce the zero-scale and full-scale errors in most applications. However, there are limitations whereby the errors may not be sufficiently removed. For example, the offset (C) register can only be used to reduce the offset caused by the negative zero-scale error. A positive offset cannot be reduced. Likewise, if the maximum voltage is below the ideal value, i.e. a negative full-scale error, the gain (M) register cannot be used to increase the gain to compensate for the error.

These limitations can be overcome by increasing the reference value. With a 3V reference a 12V span will be achieved. The ideal voltage range, for the AD5371, would be -4V to +8V. Using a 3.1V reference would increase the range to -4.133V to +8.2667V. Clearly, in this case, the offset and gain errors are insignificant and the M and C registers can be used to raise the negative voltage to -4V and then reduce the maximum voltage down to +8V to give the most accurate values possible.

## RESET FUNCTION

When the RESET pin is taken low, the DAC buffers are disconnected and the DAC outputs VOUT0 to VOUT39 are tied to their associated SIGGND signals via a 10 kΩ resistor. On the rising edge of RESET the AD5370 state machine initiates a reset sequence to reset the X, M and C registers to their default values. This sequence typically takes 300μs and the user should not write to the part during this time. When the reset sequence is complete, and provided that CLR is high, the DAC output will be at a potential specified by the default register settings which will be equivalent to SIGGND. The DAC outputs will remain at SIGGND until the X, M or C registers are updated and LDAC is taken low.

## CLEAR FUNCTION

CLR is an active low input which should be high for normal operation. The CLR pin has an internal 500kΩ pull-down resistor. When CLR is low, the input to each of the DAC output buffer stages, VOUT0 to VOUT39, is switched to the externally set potential on the relevant SIGGND pin. While CLR is low, all LDAC pulses are ignored. When CLR is taken high again, the DAC outputs remain cleared until LDAC is taken low. The contents of input registers and DAC registers 0 to 39 are not affected by taking CLR low. To prevent glitches appearing on the outputs CLR should be brought low whenever the output span is adjusted by writing to the offset DAC.

## BUSY AND LDAC FUNCTIONS

The value of an X2 (A or B) register is calculated each time the user writes new data to the corresponding X1, C, or M registers. During the calculation of X2, the BUSY output goes low. While BUSY is low, the user can continue writing new data to the X1, M, or C registers, but no DAC output updates can take place. The DAC outputs are updated by taking the LDAC input low. If LDAC goes low while BUSY is active, the LDAC event is stored and the DAC outputs update immediately after BUSY goes high. A user can also hold the LDAC input permanently low. In this case, the DAC outputs update immediately after BUSY goes high. BUSY also goes low, for approximately 500ns, whenever the A/B Select Registers are written to.

The BUSY pin is bidirectional and has a 50 kΩ internal pullup resistor. Where multiple AD5370 devices may be used in one system the BUSY pins can be tied together. This is useful where it is required that no DAC in any device is updated until all other DACs are ready. When each device has finished updating the X2 (A or B) registers it will release the BUSY pin. If another device hasn't finished updating its X2 registers it will hold BUSY low, thus delaying the effect of LDAC going low.

The DAC outputs are updated by taking the LDAC input low. If LDAC goes low while BUSY is active, the LDAC event is stored

and the DAC outputs update immediately after BUSY goes high. A user can also hold the LDAC input permanently low. In this case, the DAC outputs update immediately after BUSY goes high.

As described later, the AD5370 has flexible addressing that allows writing of data to a single channel, all channels in a group, the same channel in groups 0 to 4 or groups 1 to 4, or all channels in the device. This means that 1, 5, 8 or 40 X2 register values may need to be calculated and updated. As there is only one multiplier shared between 40 channels, this task must be done sequentially, so the length of the BUSY pulse will vary according to the number of channels being updated.

Table 7. BUSY Pulse Widths

| Action                                   | BUSY Pulse Width (μs max) |
|------------------------------------------|---------------------------|
| Loading X1A, X1B, C, or M to 1 channel   | 1.25                      |
| Loading X1A, X1B, C, or M to 5 channels  | 3.25                      |
| Loading X1A, X1B, C, or M to 8 channels  | 4.75                      |
| Loading X1A, X1B, C, or M to 40 channels | 20.75                     |

$$\text{BUSY Pulse Width} = ((\text{Number of Channels} + 1) \times 500\text{ns}) + 250\text{ns}$$

The AD5370 contains an extra feature whereby a DAC register is not updated unless its X2A or X2B register has been written to since the last time LDAC was brought low. Normally, when LDAC is brought low, the DAC registers are filled with the contents of the X2A or X2B registers, depending on the setting of the A/B Select Registers. However the AD5370 updates the DAC register only if the X2 data has changed, thereby removing unnecessary digital crosstalk.

## POWER-DOWN MODE

The AD5370 can be powered down by setting Bit 0 in the control register. This will turn off the DACs thus reducing the current consumption. The DAC outputs will be connected to their respective SIGGND potentials. The power-down mode doesn't change the contents of the registers and the DACs will return to their previous voltage when the power-down bit is cleared.

## THERMAL MONITOR FUNCTION

The AD5370 can be programmed to power down the DACs if the temperature on the die exceeds 130°C. Setting Bit 1 in the control register (see Table 12) will enable this function. If the die temperature exceeds 130°C the AD5370 will enter a temperature power-down mode, which is equivalent to setting the power-down bit in the control register. To indicate that the AD5370 has entered temperature shutdown mode Bit 4 of the control register is set. The AD5370 will remain in temperature power-down mode, even if the die temperature falls, until Bit 1 in the control register is cleared.

**TOGGLE MODE**

The AD5370 has two X2 registers per channel, X2A and X2B, which can be used to switch the DAC output between two levels with ease. This approach greatly reduces the overhead required by a micro-processor which would otherwise have to write to each channel individually. When the user writes to either the X1A, X2A, M or C registers the calculation engine will take a certain amount of time to calculate the appropriate X2A or X2B values. If the application only requires that the DAC output switch between two levels, such as a data generator, any method which reduces the amount of calculation time encountered is advantageous. For the data generator example the user need only set the high and low levels for each channel once, by writing to the X1A and X1B registers. The values of X2A and X2B will be calculated and stored in their respective registers. The calculation delay therefore only happens during the setup phase, i.e. when programming the initial values. To toggle a DAC output between the two levels it is only required to write to the relevant A/B Select Register to set the MUX2 register bit. Furthermore, since there are 8 MUX2 control bits per register it is possible to update eight channels with a single write. Table 14 shows the bits that correspond to each DAC output.

## SERIAL INTERFACE

The AD5370 contains a high-speed SPI serial interface operating at clock frequencies up to 50MHz (20MHz for read operations). To minimize both the power consumption of the device and on-chip digital noise, the interface powers up fully only when the device is being written to, that is, on the falling edge of  $\overline{\text{SYNC}}$ .

The serial interface is 2.5 V LVTTTL compatible when operating from a 2.7 V to 3.6 V  $\text{DV}_{\text{CC}}$  supply. It is controlled by four pins, as follows.

### $\overline{\text{SYNC}}$

Frame synchronization input.

### $\text{SDI}$

Serial data input pin.

### $\text{SCLK}$

Clocks data in and out of the device.

### $\text{SDO}$

Serial data output pin for data readback.

## SPI WRITE MODE

The AD5370 allows writing of data via the serial interface to every register directly accessible to the serial interface, which is all registers except the X2A and X2B registers and the DAC registers. The X2A and X2B registers are updated when writing to the X1A, X1B, M and C registers, and the DAC registers are updated by LDAC.

The serial word (see Table 8) is 24 bits long. 14 of these bits are data bits, six bits are address bits, and two bits are mode bits that determine what is done with the data. Two bits are reserved.

The serial interface works with both a continuous and a burst (gated) serial clock. Serial data applied to SDI is clocked into the AD5370 by clock pulses applied to SCLK. The first falling edge

of  $\overline{\text{SYNC}}$  starts the write cycle. At least 24 falling clock edges must be applied to SCLK to clock in 24 bits of data, before  $\overline{\text{SYNC}}$  is taken high again. If  $\overline{\text{SYNC}}$  is taken high before the 24th falling clock edge, the write operation will be aborted.

If a continuous clock is used,  $\overline{\text{SYNC}}$  must be taken high before the 25th falling clock edge. This inhibits the clock within the AD5370. If more than 24 falling clock edges are applied before  $\overline{\text{SYNC}}$  is taken high again, the input data will be corrupted. If an externally gated clock of exactly 24 pulses is used,  $\overline{\text{SYNC}}$  may be taken high any time after the 24th falling clock edge.

The input register addressed is updated on the rising edge of  $\overline{\text{SYNC}}$ . In order for another serial transfer to take place,  $\overline{\text{SYNC}}$  must be taken low again.

## SPI READBACK MODE

The AD5370 allows data readback via the serial interface from every register directly accessible to the serial interface, which is all registers except the DAC data registers. In order to read back a register, it is first necessary to tell the AD5370 which register is to be read. This is achieved by writing to the device a word whose first two bits are the special function code 00. The remaining bits then determine if the operation is a readback, and the register which is to be read back, or if it is a write to of the special function registers such as the control register.

After the special function write has been performed, if it is a readback command then data from the selected register will be clocked out of the SDO pin during the next SPI operation. The SDO pin is normally three-state but becomes driven as soon as a read command has been issued. The pin will remain driven until the registers data has been clocked out. See Figure 5 for the read timing diagram. Note that due to the timing requirements of  $t_s$  (25ns) the maximum speed of the SPI interface during a read operation should not exceed 20MHz.

**Table 8. Serial Word Bit Assignment**

|     |     |     |     |     |     |     |     |     |     |     |     |     |     |    |    |    |    |    |    |    |    |    |    |
|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|
| I23 | I22 | I21 | I20 | I19 | I18 | I17 | I16 | I15 | I14 | I13 | I12 | I11 | I10 | I9 | I8 | I7 | I6 | I5 | I4 | I3 | I2 | I1 | I0 |
| M1  | M0  | A5  | A4  | A3  | A2  | A1  | A0  | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |

## REGISTER UPDATE RATES

As mentioned previously the value of the X2 (A or B) register is calculated each time the user writes new data to the corresponding X1, C or M registers. The calculation is performed by a three stage process. The first two stages take 500ns each and the third stage takes 250ns. When the write to one of the X1, C or M registers is complete the calculation process begins. If the write operation involves the update of a single DAC channel the user is free to write to another register provided that the write operation doesn't finish until the first stage calculation is complete, i.e. 500ns after the completion of the first write operation. If a group of channels is being updated by a single write operation the first stage calculation will be repeated for each channel, taking 500ns per channel. In this case the user should not complete the next write operation until this time has elapsed.

## CHANNEL ADDRESSING AND SPECIAL MODES

If the mode bits are not 00, then the data word D13 to D0 is written to the device. Address bits A5 to A0 determine which channel or channels is/are written to, while the mode bits

determine to which register (X1A, X1B, C or M) the data is written, as shown in Table 8. If data is to be written to the X1A or X1B register, the setting of the  $\bar{A}/B$  bit in the Control Register determines which (0  $\rightarrow$  X1A, 1  $\rightarrow$  X1B).

**Table 9. Mode Bits**

| M1 | M0 | Action                                                                                     |
|----|----|--------------------------------------------------------------------------------------------|
| 1  | 1  | Write DAC input data (X1A or X1B) register, depending on Control Register $\bar{A}/B$ bit. |
| 1  | 0  | Write DAC offset (C) register                                                              |
| 0  | 1  | Write DAC gain (M) register                                                                |
| 0  | 0  | Special function, used in combination with other bits of word                              |

The AD5370 has very flexible addressing that allows writing of data to a single channel, all channels in a group, the same channel in groups 0 to 4 or groups 1 to 4, or all channels in the device. Table 10 shows all these address modes.

**Table 10. Group and Channel Addressing**

This table shows which group(s) and which channel(s) is/are addressed for every combination of address bits A5 to A0.

|                             |     | ADDRESS BITS A5 TO A3       |                       |                       |                       |                       |                       |                               |                             |
|-----------------------------|-----|-----------------------------|-----------------------|-----------------------|-----------------------|-----------------------|-----------------------|-------------------------------|-----------------------------|
|                             |     | 000                         | 001                   | 010                   | 011                   | 100                   | 101                   | 110                           | 111                         |
| ADDRESS<br>BITS A2 TO<br>A0 | 000 | All groups,<br>all channels | Group 0,<br>channel 0 | Group 1,<br>channel 0 | Group 2,<br>channel 0 | Group 3,<br>channel 0 | Group 4,<br>channel 0 | Groups 0,1,2,3,4<br>channel 0 | Groups 1,2,3,4<br>channel 0 |
|                             | 001 | Group 0, all<br>channels    | Group 0,<br>channel 1 | Group 1,<br>channel 1 | Group 2,<br>channel 1 | Group 3,<br>channel 1 | Group 4,<br>channel 1 | Groups 0,1,2,3,4<br>channel 1 | Groups 1,2,3,4<br>channel 1 |
|                             | 010 | Group 1, all<br>channels    | Group 0,<br>channel 2 | Group 1,<br>channel 2 | Group 2,<br>channel 2 | Group 3,<br>channel 2 | Group 4,<br>channel 2 | Groups 0,1,2,3,4<br>channel 2 | Groups 1,2,3,4<br>channel 2 |
|                             | 011 | Group 2, all<br>channels    | Group 0,<br>channel 3 | Group 1,<br>channel 3 | Group 2,<br>channel 3 | Group 3,<br>channel 3 | Group 4,<br>channel 3 | Groups 0,1,2,3,4<br>channel 3 | Groups 1,2,3,4<br>channel 3 |
|                             | 100 | Group 3, all<br>channels    | Group 0,<br>channel 4 | Group 1,<br>channel 4 | Group 2,<br>channel 4 | Group 3,<br>channel 4 | Group 4,<br>channel 4 | Groups 0,1,2,3,4<br>channel 4 | Groups 1,2,3,4<br>channel 4 |
|                             | 101 | Group 4, all<br>channels    | Group 0,<br>channel 5 | Group 1,<br>channel 5 | Group 2,<br>channel 5 | Group 3,<br>channel 5 | Group 4,<br>channel 5 | Groups 0,1,2,3,4<br>channel 5 | Groups 1,2,3,4<br>channel 5 |
|                             | 110 | Reserved                    | Group 0,<br>channel 6 | Group 1,<br>channel 6 | Group 2,<br>channel 6 | Group 3,<br>channel 6 | Group 4,<br>channel 6 | Groups 0,1,2,3,4<br>channel 6 | Groups 1,2,3,4<br>channel 6 |
|                             | 111 | Reserved                    | Group 0,<br>channel 7 | Group 1,<br>channel 7 | Group 2,<br>channel 7 | Group 3,<br>channel 7 | Group 4,<br>channel 7 | Groups 0,1,2,3,4<br>channel 7 | Groups 1,2,3,4<br>channel 7 |

**SPECIAL FUNCTION MODE**

If the mode bits are 00, then the special function mode is selected, as shown in Table 11. Bits I21 to I16 of the serial data word select the special function, while the remaining bits are

data required for execution of the special function, for example the channel address for data readback.

The codes for the special functions are shown in Table 12. Table 13 shows the addresses for data readback.

**Table 11. Special Function Mode**

| I23 | I22 | I21 | I20 | I19 | I18 | I17 | I16 | I15 | I14 | I13 | I12 | I11 | I10 | I9 | I8 | I7 | I6 | I5 | I4 | I3 | I2 | I1 | I0 |
|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|
| 0   | 0   | S5  | S4  | S3  | S2  | S1  | S0  | F15 | F14 | F13 | F12 | F11 | F10 | F9 | F8 | F7 | F6 | F5 | F4 | F3 | F2 | F1 | F0 |

**Table 12. Special Function Codes**

| SPECIAL FUNCTION CODE |    |    |    |    |    | DATA                    | ACTION                                                                                                                                                                                                                                           |
|-----------------------|----|----|----|----|----|-------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| S5                    | S4 | S3 | S2 | S1 | S0 | F15-F0                  |                                                                                                                                                                                                                                                  |
| 0                     | 0  | 0  | 0  | 0  | 0  | 0000 0000 0000 0000     | NOP                                                                                                                                                                                                                                              |
| 0                     | 0  | 0  | 0  | 0  | 1  | XXXX XXXX XXXX X[F2:F0] | Write control register<br>F2 = 1 → Select B register for input.<br>F2 = 0 → Select A register for input.<br>F1 = 1 → Enable temperature shutdown.<br>F1 = 0 → Disable temperature shutdown.<br>F0 = 1 → Soft power down; F0 = 0 → Soft power up. |
| 0                     | 0  | 0  | 0  | 1  | 0  | XX[F13:F0]              | Write data in F13:F0 to OFS0 register                                                                                                                                                                                                            |
| 0                     | 0  | 0  | 0  | 1  | 1  | XX[F13:F0]              | Write data in F13:F0 to OFS1 register                                                                                                                                                                                                            |
| 0                     | 0  | 0  | 1  | 0  | 0  | XX[F13:F0]              | Reserved                                                                                                                                                                                                                                         |
| 0                     | 0  | 0  | 1  | 0  | 1  | See Table 13            | Select register for readback                                                                                                                                                                                                                     |
| 0                     | 0  | 0  | 1  | 1  | 0  | XXXX XXXX[F7:F0]        | Write data in F7:F0 to A/B Select Register 0                                                                                                                                                                                                     |
| 0                     | 0  | 0  | 1  | 1  | 1  | XXXX XXXX[F7:F0]        | Write data in F7:F0 to A/B Select Register 1                                                                                                                                                                                                     |
| 0                     | 0  | 1  | 0  | 0  | 0  | XXXX XXXX[F7:F0]        | Write data in F7:F0 to A/B Select Register 2                                                                                                                                                                                                     |
| 0                     | 0  | 1  | 0  | 0  | 1  | XXXX XXXX[F7:F0]        | Write data in F7:F0 to A/B Select Register 3                                                                                                                                                                                                     |
| 0                     | 0  | 1  | 0  | 1  | 0  | XXXX XXXX[F7:F0]        | Write data in F7:F0 to A/B Select Register 4                                                                                                                                                                                                     |
| 0                     | 0  | 1  | 0  | 1  | 1  | XXXX XXXX [F7:F0]       | Block write A/B Select Registers<br>F7:F0 = 0, write all 0's (all channels use X2A register)<br>F7:F0 = 1, wrote all 1's (all channels use X2B register)                                                                                         |

Table 13. Address Codes for Data Readback

| F15 | F14 | F13 | F12                                                                                           | F11 | F10 | F9 | F8 | F7 | REGISTER READ         |
|-----|-----|-----|-----------------------------------------------------------------------------------------------|-----|-----|----|----|----|-----------------------|
| 0   | 0   | 0   | Bits F12 to F7 select channel to be read back, from Channel 0 = 001000 to Channel 39 = 101111 |     |     |    |    |    | X1A Register          |
| 0   | 0   | 1   |                                                                                               |     |     |    |    |    | X1B Register          |
| 0   | 1   | 0   |                                                                                               |     |     |    |    |    | C Register            |
| 0   | 1   | 1   |                                                                                               |     |     |    |    |    | M Register            |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 0  | 0  | 1  | Control Register      |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 0  | 1  | 0  | OFS0 Data Register    |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 0  | 1  | 1  | OFS1 Data Register    |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 1  | 0  | 0  | Reserved              |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 1  | 1  | 0  | A/B Select Register 0 |
| 1   | 0   | 0   | 0                                                                                             | 0   | 0   | 1  | 1  | 1  | A/B Select Register 1 |
| 1   | 0   | 0   | 0                                                                                             | 0   | 1   | 0  | 0  | 0  | A/B Select Register 2 |
| 1   | 0   | 0   | 0                                                                                             | 0   | 1   | 0  | 0  | 1  | A/B Select Register 3 |
| 1   | 0   | 0   | 0                                                                                             | 0   | 1   | 0  | 1  | 0  | A/B Select Register 4 |

Table 14. DACs Select by A/B Select Registers

| A/B Select Register | Bits   |        |        |        |        |        |        |        |
|---------------------|--------|--------|--------|--------|--------|--------|--------|--------|
|                     | F7     | F6     | F5     | F4     | F3     | F2     | F1     | F0     |
| 0                   | VOUT7  | VOUT6  | VOUT5  | VOUT4  | VOUT3  | VOUT2  | VOUT1  | VOUT0  |
| 1                   | VOUT15 | VOUT14 | VOUT13 | VOUT12 | VOUT11 | VOUT10 | VOUT9  | VOUT8  |
| 2                   | VOUT23 | VOUT22 | VOUT21 | VOUT20 | VOUT19 | VOUT18 | VOUT17 | VOUT16 |
| 3                   | VOUT31 | VOUT30 | VOUT29 | VOUT28 | VOUT27 | VOUT26 | VOUT25 | VOUT24 |
| 4                   | VOUT39 | VOUT38 | VOUT37 | VOUT36 | VOUT35 | VOUT34 | VOUT33 | VOUT32 |

## POWER SUPPLY DECOUPLING

In any circuit where accuracy is important, careful consideration of the power supply and ground return layout helps to ensure the rated performance. The printed circuit board on which the AD5370 is mounted should be designed so that the analog and digital sections are separated and confined to certain areas of the board. If the AD5370 is in a system where multiple devices require an AGND-to-DGND connection, the connection should be made at one point only. The star ground point should be established as close as possible to the device. For supplies with multiple pins ( $V_{SS}$ ,  $V_{DD}$ ,  $V_{CC}$ ), it is recommended to tie these pins together and to decouple each supply once.

The AD5370 should have ample supply decoupling of 10  $\mu\text{F}$  in parallel with 0.1  $\mu\text{F}$  on each supply located as close to the package as possible, ideally right up against the device. The 10 $\mu\text{F}$  capacitors are the tantalum bead type. The 0.1  $\mu\text{F}$  capacitor should have low effective series resistance (ESR) and effective series inductance (ESI), such as the common ceramic types that provide a low impedance path to ground at high frequencies, to handle transient currents due to internal logic switching.

Digital lines running under the device should be avoided, because these couple noise onto the device. The analog ground plane should be allowed to run under the AD5370 to avoid noise coupling. The power supply lines of the AD5370 should use as large a trace as possible to provide low impedance paths and reduce the effects of glitches on the power supply line. Fast switching digital signals should be shielded with digital ground to avoid radiating noise to other parts of the board, and should never be run near the reference inputs. It is essential to minimize noise on all  $V_{REF}$  lines. Avoid crossover of digital and analog signals. Traces on opposite sides of the board should run at right angles to each other. This reduces the effects of feedthrough through the board. A microstrip technique is by far the best, but not always possible with a double-sided board. In this technique, the component side of the board is dedicated to ground plane, while signal traces are placed on the solder side.

As is the case for all thin packages, care must be taken to avoid flexing the package and to avoid a point load on the surface of this package during the assembly process.

## POWER SUPPLY SEQUENCING

When the supplies are connected to the AD5370 it is important that the AGND and DGND pins are connected to the relevant ground plane before the positive or negative supplies are applied. In most applications this is not an issue as the ground pins for the power supplies will be connected to the ground pins of the AD5370 via ground planes. Where the AD5370 is to be used in a hot-swap card care should be taken to ensure that the ground pins are connected to the supply grounds before the positive or negative supplies are connected. This is required to prevent currents flowing in directions other than towards an analog or digital ground.

## INTERFACING EXAMPLES

The SPI interface of the AD5370 is designed to allow the parts to be easily connected to industry standard DSPs and micro-controllers. Figure 11 shows how the AD5370 could be connected to the Analog Devices Blackfin<sup>®</sup> DSP. The Blackfin has an integrated SPI port which can be connected directly to the SPI pins of the AD5370 and programmable I/O pins which can be used to set or read the state of the digital input or output pins associated with the interface.

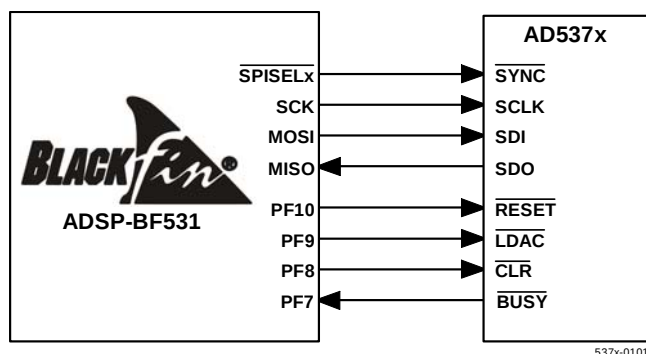


Figure 11. Interfacing to a Blackfin DSP

The Analog Devices ADSP-21065L is a floating point DSP with two serial ports (SPORTS). Figure 12 shows how one SPORT can be used to control the AD5370. In this example the Transmit Frame Synchronization (TFS) pin is connected to the Receive Frame Synchronization (RFS) pin. Similarly the transmit and receive clocks (TCLK and RCLK) are also connected together. The user can write to the AD5370 by writing to the transmit register. A read operation can be accomplished by first writing to the AD5370 to tell the part that a read operation is required. A second write operation with a NOP instruction will cause the data to be read from the AD5370. The DSPs receive interrupt can be used to indicate when the read operation is complete.

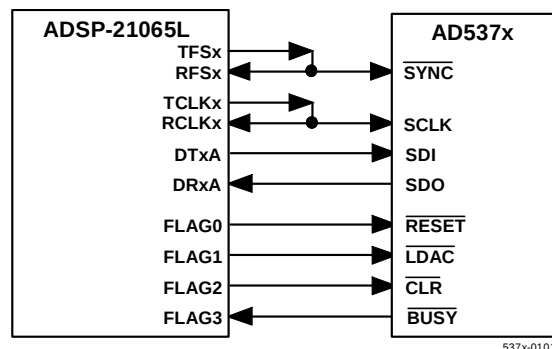


Figure 12. Interfacing to an ADSP-21065L DSP

## OUTLINE DIMENSIONS

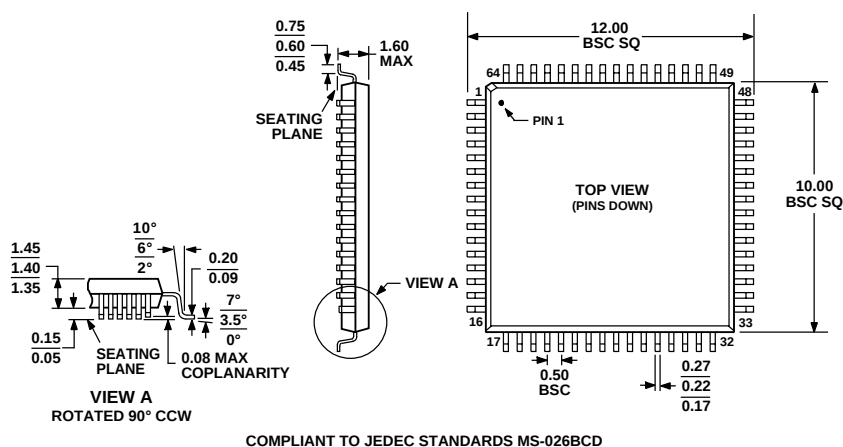


Figure 13. 64-Lead Low Profile Quad Flat Package [LQFP]  
(ST-64-2)

Dimensions shown in millimeters

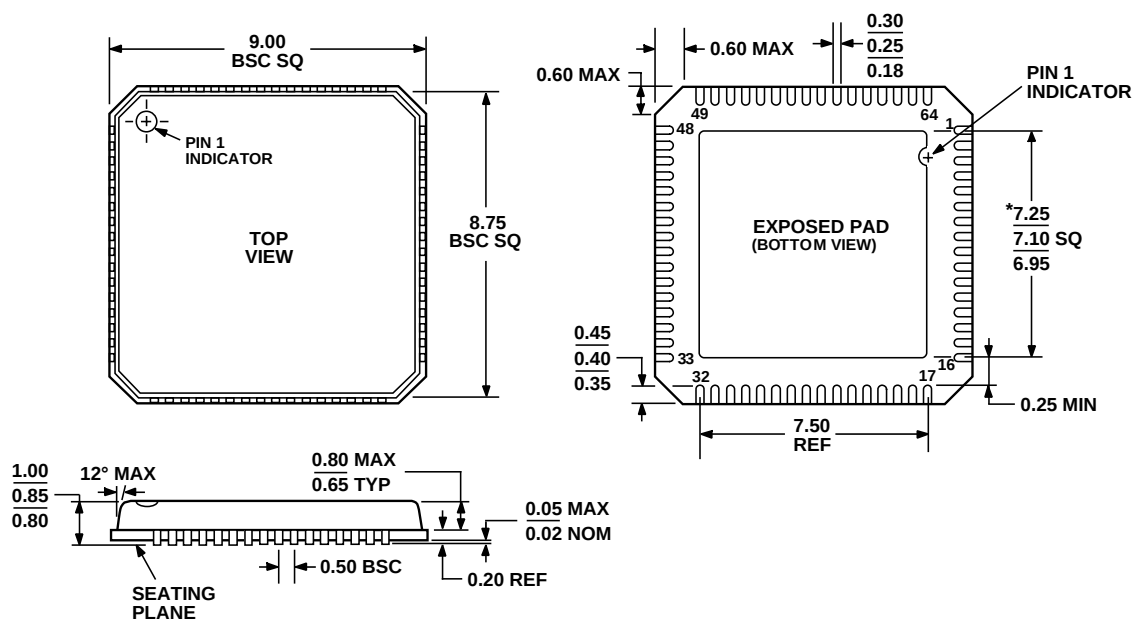


Figure 14. 64-Lead Free Chip Scale Package [LFCS]  
(CP-64-3)

Dimensions shown in millimeters

## ORDERING GUIDE

| Model      | Temperature Range | Package Description                    | Package Option |
|------------|-------------------|----------------------------------------|----------------|
| AD5370BSTZ | -40°C to +85°C    | 64-Lead Quad Flat Pack (LQFP)          | ST-64          |
| AD5370BCPZ | -40°C to +85°C    | 64-Lead Free Chip Scale Package (LFCS) | CP-64          |

## NOTES